



Low Voltage Bidirectional SPDT Analog Switch

Description

The DIODES PSMUX1248 is a general purpose SPDT CMOS Analog Switch. It can be used as an analog switch or as a low-delay bus switch. Specified over a wide operating power supply voltage, 1.08V to 5.5V.

Break-before-make switching prevents both switches being enabled simultaneously. This eliminates signal disruption during switching.

The device supports bidirectional analog and digital signals on the source (Sx) and drain (D) pins ranging from GND to $V_{\rm DD}$. A low supply current of 4nA enables use in portable applications.

All logic inputs have 1.8V logic compatible thresholds, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range.

Application(s)

- PC Motherboards
- Notebooks
- Servers
- Smartphones
- Remote Radio Units
- Active Antenna System mMIMO (AAS)
- Barcode Scanners
- Motor Drives
- Building Automation
- Video Surveillance
- Electronic Point of Sales
- Appliances
- Consumer Audio

Features

- Wide V_{DD} Range: 1.08V to 5.5V
- Low Supply Current: 4nA
- Low On-Resistance 3Ω
- 1.8 V Logic Compatible
- Voltages on the control pins to be applied before the supply pin
- Signal Passing Bandwidth, 500MHz
- Transition Time: 14ns
- Break-before-make Switching
- Rail-to-Rail Signal Range
- High Off Isolation: -65dB @ 1MHz
- Crosstalk Rejection Reduces Signal Distortion: -65dB @ 1MHz
- Extended Industrial Temperature Range: -40°C to 125°C
- ESD Protection : 2kV(HBM)
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

- Packaging (Pb-free & Green):
 - 6-pin SC-70 (C)

Function Table

SEL	Source (Sx) Connected To D Pin
0	S1
1	S2

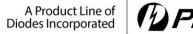
Notes

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

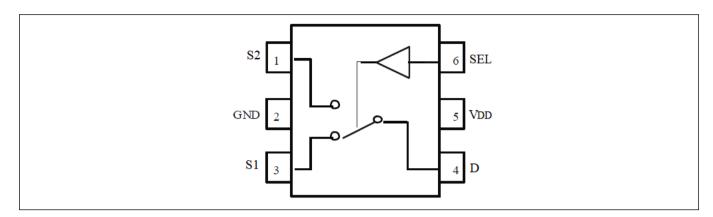
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.







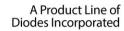
Pin Configuration



Pin Description

Pin#	Pin Name	Type	Description
1	S2	I/O	Data port 2
2	GND	Power	Ground
3	S1	I/O	Data Port 1
4	D	I/O	Common Data pin.
5	V_{DD}	Power	Positive Power Supply
6	SEL	I	Selection Pin







Maximum Ratings

Storage Temperature	65°C to +150°C
Ambient Temperature with Power Applied	40°C to +125°C
Supply Voltage V _{DD}	0.5V to +6V
Control Input Voltage SEL	0.5V to +6V
DC Input Voltage V _{INPUT}	0.5V to +6V
Continuous Current S1/S2/D	±50mA
ESD (HBM)	2kV
ESD (CDM)	1kV

Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

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The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed. Control input must be held HIGH or LOW; it must not float.

Recommended Operating Conditions

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V_{DD}	Operating Voltage		1.08		5.5	V
V _S or V _D	Control Input Voltage		0		V_{DD}	V
V _{SEL}	Select Input Voltage		0		5.5	V
T _A	Operating Temperature		-40	25	125	°C

DC Electrical Characteristics

+5V	Sunn	lv (Vdd	= 5V	+10%)

Symbol	Parameter	Test Conditions	T _A	Min.	Тур.	Max.	Units
ANALOG SWI	ТСН						
V_S, V_D	Analog Signal Range			0		V_{DD}	V
		Y 40 4 YY 0	25°C		3		
R _{ON}	On-Resistance	$I_{SD} = 10 \text{mA}, V_S = 0 \text{ to}$ V_{DD} , Test Circuit 1	-40°C to 85°C			5	Ω
		V DD, Test Circuit I	-40°C to 125°C			6	
	On-resistance matching		25°C		0.15		
Δ R _{ON}	between	$I_{SD} = 10$ mA, $V_{S} = 0$ to V_{DD} , Test Circuit 1	-40°C to 85°C			1	Ω
	channels	V DD, Test Circuit I	-40°C to 125°C			1	
			25°C		1.5		
R _{ONF}	On-Resistance Flatness	$I_{SD} = 10 \text{mA}, V_S = 0 \text{ to}$ V_{DD} , Test Circuit 1	-40°C to 85°C		2		Ω
	Tauless	VDD, Test Circuit I	-40°C to 125°C		3		
		$V_D = 4.5 V / 1.5 V$	25°C		±75		
I _{S (OFF)}	S Off Leakage Current	$V_S = 1.5V/4.5V$, Switch OFF	-40°C to 85°C	-150		150	nA
			-40°C to 125°C	-175		175	
			25°C		±200		
$I_{S (ON)}$ or $I_{D (ON)}$	S/D ON Leakage Current	$V_D = V_S = 4.5V/1V$ Switch ON	-40°C to 85°C	-500		500	nA
	Leakage Current	Switch Oil	-40°C to 125°C	-750		750	
SELECT INPU	UTS (SEL)						
V_{IH}	Input Logic High		-40°C to 125°C	1.42		5.5	V
$V_{\rm IL}$	Input Logic Low		-40°C to 125°C	0		0.75	V
I_{IH}	Input Leakage		+25°C		±5		4
I_{IL}	Current		-40°C to 125°C			±50	nA
C	D: 1/1 / 1/	C 1MII	+25°C		1		Г
C_{IN}	Digital input capacitance	I = IMHZ	-40°C to 125°C			2	pF
DYNAMIC CH	IARACTERISTICS					•	
	Switching time between	$V_S = 3V, R_L = 200\Omega, C_L$	25°C		12		
t_{TRAN}	channels	= 15pF	-40°C to 85°C			18	ns





Symbol	Parameter	Test Conditions	T _A	Min.	Тур.	Max.	Units
			-40°C to 125°C			19	
	D 1 D 6 1/1		25°C		8		
t_{BBM}	Break-Before-Make Delay	$V_S = 3V, R_L = 200\Omega, C_L = 15pF$	-40°C to 85°C	1			ns
	Delay	- 13pr	-40°C to 125°C	1			
Qc	Charge injection	$\begin{aligned} V_S &= V_{DD}/2; R_S = 0\Omega, \\ C_L &= 1nF \end{aligned}$	+25°C		-10		pC
0	Off Isolations	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$			-65		dB
${ m O_{ISO}}$	Off Isolations	$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$			-45		
X_{TALKD}	Channel-to-Channel	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-65		dB
ATALKD	Crosstalk	$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-45		ųБ
f_{3dB}	3dB Bandwidth	$R_L = 50\Omega$, $C_L = 5pF$	+25°C		500		MHz
C _{S (OFF)}	S Channels Off Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch OFF. $f = 1MHz$	25°C		7		pF
$C_{S(ON)}$	S Channels On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1$ MHz	25°C		23		pF
$C_{D(ON)}$	D Channel On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1$ MHz	25°C		23		pF
SUPPLY							
T	Dorron Cumply Cumpet	$V_{SEL} = GND \text{ or } 5.5V,$	+25°C		0.007		
I_{DD}	Power Supply Current	Switch ON or OFF	-40°C to 125°C			1.5	μA

+3.3V Supply $(V_{DD} = 3.3V \pm 10\%)$

Symbol	Parameter	Test Conditions	$T_{\mathbf{A}}$	Min.	Typ.	Max.	Units
ANALOG SWI	ТСН	•					
V_S, V_D	Analog Signal Range			0		V_{DD}	V
	T	- 10 1 0	25 °C		4.5		
Ron	On-Resistance	$I_{SD} = 10$ mA, $V_{S} = 0$ to V_{DD} , Test Circuit 1	-40°C to 85°C			12.5	Ω
		VDD, Test Circuit I	-40°C to 125°C			13	
	On-resistance matching	- 10 1 0	25 °C		0.15		
Δ R _{ON}	between	$I_{SD} = 10$ mA, $V_{S} = 0$ to V_{DD} , Test Circuit 1	-40°C to 85°C			1	Ω
	channels	V _{DD} , Test Circuit I	-40°C to 125°C			1	
			25 °C		3.5		
R_{ONF}	On-Resistance Flatness	$I_{SD} = 10 \text{mA}, V_S = 0 \text{ to}$ V_{DD} , Test Circuit 1	-40°C to 85°C		4		Ω
	Tradiess		-40°C to 125°C		5		
		$V_{\rm D} = 3V/1V$	25 °C		±75		
$I_{S(OFF)}$	S Off Leakage Current	$V_S = 1V/3V$	-40°C to 85°C	-150		150	nA
	Leakage Current	Switch OFF	-40°C to 125°C	-175		175	
			25 °C		±200		
$I_{S(ON)}$ or $I_{D(ON)}$	S/D ON Leakage Current	$V_D = V_S = 3V/1V$ Switch ON	-40°C to 85°C	-500		500	nA
	Leakage Current	Switch Oiv	-40°C to 125°C	-750		750	
SELECT INPU	TTS (SEL)						
V_{IH}	Input Logic High		-40°C to 125°C	1.35		5.5	V
V_{IL}	Input Logic Low		-40°C to 125°C	0		0.65	V
I_{IH}	Input Leakage		+25°C		±5		A
I_{IL}	Current		-40°C to 125°C			±50	nA





Symbol	Parameter	Test Conditions	TA	Min.	Тур.	Max.	Units
C	D: :(1: 4 : :	C 1MII	+25°C		1		F
C_{IN}	Digital input capacitance	f = 1MHz	-40°C to 125°C			2	pF
DYNAMIC (CHARACTERISTICS						
	0.11.11.11	av b acca	25 °C		14		
t_{TRAN}	Switching time between channels	$V_S = 2V, R_L = 200\Omega,$ $C_L = 15pF$	-40°C to 85°C			20	ns
	chamers	CL = 13pr	-40°C to 125°C			22	
	D 1 D C M1		25 °C		8		
$t_{\rm BBM}$	Break-Before-Make Delay	$V_S = 2V, R_L = 200\Omega,$ $C_L = 15pF$	-40°C to 85°C	1			ns
	Delay	CL = 13pr	-40°C to 125°C	1			
Qc	Charge injection	$\label{eq:VS} \begin{aligned} V_S &= V_{DD}/2; \ R_S &= 0\Omega, \\ C_L &= 1nF \end{aligned}$	+25°C		-6		pC
0	occi. 1	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-65		dB
O _{ISO}	Off Isolations	$R_L = 50\Omega$, $C_L = 5pF$, f = 10MHz	+25°C		-45		
V	Channel-to-Channel	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-65		ID.
X_{TALKD}	Crosstalk	$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-45		dB
f _{3dB}	3dB Bandwidth	$R_L = 50\Omega$, $C_L = 5pF$	+25°C		500		MHz
C _{S (OFF)}	S Channels Off Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch OFF. $f = 1$ MHz	25°C		7		pF
C _{S (ON)}	S Channels On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1MHz$	25°C		23		pF
C _{D (ON)}	D Channel On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1MHz$	25°C		23		pF
SUPPLY							
Ţ	Dower Supply Current	V_{SEL} = GND or 5.5V,	+25°C		0.004		
I_{DD}	Power Supply Current	Switch ON or OFF	-40°C to 125°C			0.8	μΑ

+1.8V Supply $(V_{DD} = 1.8V \pm 10\%)$

Symbol	Parameter	Test Conditions	T _A	Min.	Тур.	Max.	Units
ANALOG SWI	ТСН	•					
V_S, V_D	Analog Signal Range			0		V_{DD}	V
			25°C		40		
R _{ON}	On-Resistance	V _{DD} , Test Circuit I	-40°C to 85°C			80	Ω
			-40°C to 125°C			80	
	On-resistance matching		25°C		0.4		Ω
Δ R _{ON}	between channels	$I_{SD} = 10 \text{mA}, V_S = 0 \text{ to}$ V_{DD} , Test Circuit 1	-40°C to 85°C			1.5	
			-40°C to 125°C			1.5	
		$V_D = 1.8V/1V$	25°C		±75		nA
I _{S (OFF)}	S Off Leakage Current	$V_S = 1V/1.8V$,	-40°C to 85°C	-150		150	
	Leakage Current	Switch OFF	-40°C to 125°C	-175		175	
	an ou	** ** ***	25°C		±200		
$I_{S(ON)} or I_{D(ON)}$	S/D ON Leakage Current	$V_D = V_S = 1.8V/1V$ Switch ON	-40°C to 85°C	-500		500	nA
	Leakage Current	SWILCH ON	-40°C to 125°C	-750		750	1
SELECT INPU	JTS (SEL)						
V _{IH}	Input Logic High		-40°C to 125°C	1.07		5.5	V



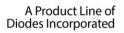


Symbol	Parameter	Test Conditions	TA	Min.	Тур.	Max.	Units
$V_{\rm IL}$	Input Logic Low		-40°C to 125°C	0		0.55	V
$ m I_{IH}$	Input Leakage		+25°C		±5		
I_{IL}	Current		-40°C to 125°C			±50	nA
<u> </u>	51.1.11	S 43.677	+25°C		1		
C_{IN}	Digital input capacitance	f = 1MHz	-40°C to 125°C			2	pF
DYNAMIC (CHARACTERISTICS	1			l		
			25°C		24		
t _{TRAN}	Switching time between	$V_S = 1V, R_L = 200\Omega, C_L$	-40°C to 85°C			44	ns
	channels	=15pF	-40°C to 125°C			45	
			25°C		16		
t_{BBM}	Break-Before-Make	$V_S = 1V, R_L = 200\Omega, C$	-40°C to 85°C	1			ns
	Delay	$_{L}$ = 15pF	-40°C to 125°C	1			
Qc	Charge injection	$V_S = V_{DD}/2; R_S = 0\Omega,$ $C_L = 1 nF$	+25°C		-3		pC
0	and the	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-65		410
O _{ISO}	Off Isolations	$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-45		dB
V	Channel-to-Channel	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-65		4D
X_{TALKD}	Crosstalk	$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-45		dB
f_{3dB}	3dB Bandwidth	$R_L = 50\Omega$, $C_L = 5pF$	+25°C		500		MHz
C _{S (OFF)}	S Channels Off Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch OFF. $f = 1MHz$	25°C		7		pF
C _{S (ON)}	S Channels On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1MHz$	25°C		23		pF
C _{D (ON)}	D Channel On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1$ MHz	25°C		23		pF
SUPPLY							
т	D C 1 . C	V_{SEL} = GND or 5.5 V_{\odot}	+25°C		0.002		4
I_{DD}	Power Supply Current	Switch ON or OFF	-40°C to 125°C			0.52	μA

+1.2V Supply $(V_{DD} = 1.2V \pm 10\%)$

Symbol	Parameter	Test Conditions	TA	Min.	Тур.	Max.	Units
ANALOG SWI	ТСН	•					
V_S, V_D	Analog Signal Range			0		V_{DD}	V
		I 10 A IV 0	25°C		70		
R _{ON}	On-Resistance	$I_{SD} = 10$ mA, $V_{S} = 0$ to V_{DD} , Test Circuit 1	-40°C to 85°C			105	Ω
		VDD, Test Circuit 1	-40°C to 125°C			105	
	On-resistance matching between channels	$I_{SD} = 10$ mA, $V_S = 0$ to V_{DD} , Test Circuit 1	25°C		0.4		
$\Delta R_{\rm ON}$			-40°C to 85°C			1.5	Ω
			-40°C to 125°C			1.5	
	g o.cc	$V_D = 1.2V/1V$	25°C		±75		
I _{S (OFF)}	S Off Leakage Current	$V_S = 1V/1.2V$,	-40°C to 85°C	-150		150	nA
	Leakage Current	Switch OFF	-40°C to 125°C	-175		175	
	an ou	** ** ***	25°C		±200		
$I_{S(ON)} or I_{D(ON)}$	S/D ON Leakage Current	$V_D = V_S = 1.2V/1V$ Switch ON	-40°C to 85°C	-500		500	nA
	Leakage Current		-40°C to 125°C	-750		750	







Symbol	Parameter	Test Conditions	TA	Min.	Тур.	Max.	Units	
SELECT IN	PUTS (SEL)							
V _{IH}	Input Logic High		-40°C to 125°C	0.96			V	
V _{IL}	Input Logic Low		-40°C to 125°C			0.36	V	
I _{IH}	Input Leakage Current		+25°C		±5		nA	
I_{IL}			-40 °C to 125°C			±100		
C_{IN}	Digital input capacitance	f = 1MHz	+25°C		1		pF	
			-40°C to 125°C			2		
DYNAMIC (CHARACTERISTICS							
t _{TRAN}	Switching time between channels	$V_S = 1V, R_L = 200\Omega, C_L = 15pF$	25°C		40		ns	
			-40°C to 85°C			175		
			-40°C to 125°C			175		
t _{BBM}	Break-Before-Make Delay	$V_S = 1V, R_L = 200\Omega, C_L = 15pF$	25°C		27		ns	
			-40°C to 85°C	1				
			-40°C to 125°C	1				
Qc	Charge injection	$V_S = V_{DD}/2; R_S = 0, C_L$ = 1nF	+25°C		±5		pC	
O _{ISO}	Off Isolations	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-64		— dB	
		$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-44			
X_{TALKD}	Channel-to-Channel Crosstalk	$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$	+25°C		-64		dB	
		$R_L = 50\Omega$, $C_L = 5pF$, $f = 10MHz$	+25°C		-44		aB	
f_{3dB}	3dB Bandwidth	$R_L = 50\Omega$, $C_L = 5pF$	+25°C		500		MHz	
C _{S (OFF)}	S Channels Off Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch OFF. $f = 1MHz$	25°C		7		pF	
C _{S (ON)}	S Channels On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch OFF. $f = 1MHz$	25°C		23		pF	
C _{D (ON)}	D Channel On Capacitance	$V_{Sx} = V_{DD}$ or GND, Switch ON. $f = 1MHz$	25°C		23		pF	
SUPPLY								
I_{DD}	Power Supply Current	V _{SEL} = GND or 5.5V, Switch ON or OFF	+25°C		0.0015		.,, Λ	
			-40°C to 85°C			0.45	uA	





Test Circuits and Timing Diagrams

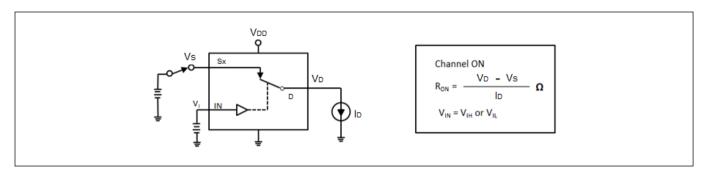


Figure 1. On Resistance

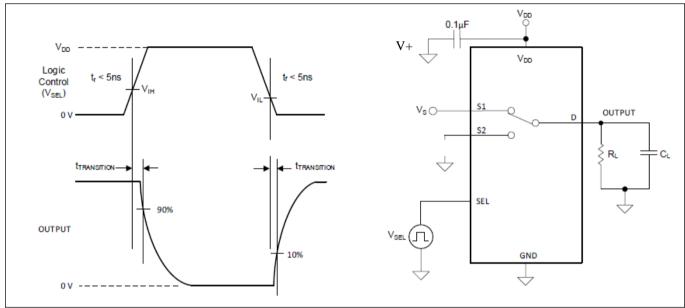


Figure 2. Transition Time

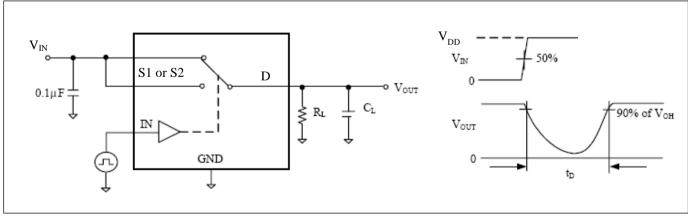


Figure 3. Break Before Make Interval Timing





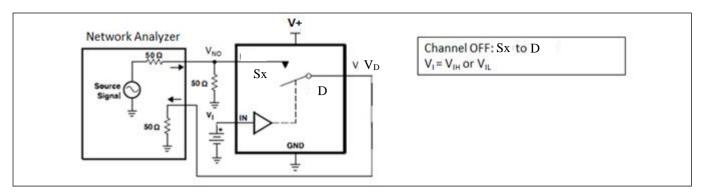


Figure 4. OFF Isolation (O_{ISO})

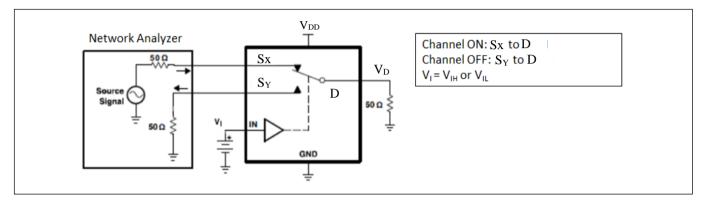


Figure 5. Crosstalk

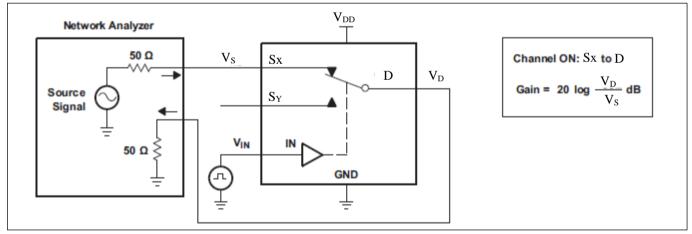


Figure 6. Bandwidth



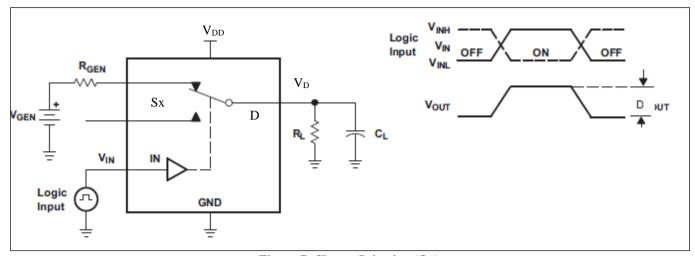


Figure 7. Charge Injection (Qc)

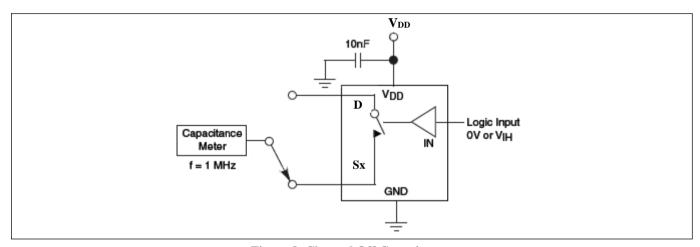


Figure 8. Channel Off Capacitance

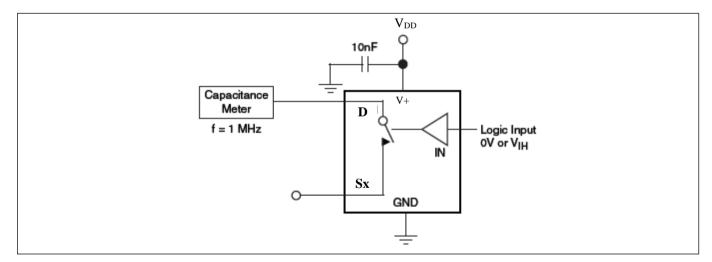


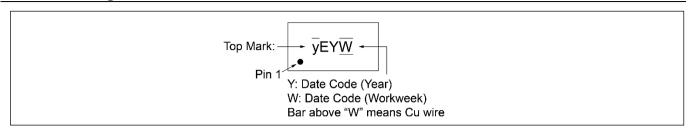
Figure 9. Channel On Capacitance



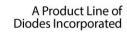




Part Marking

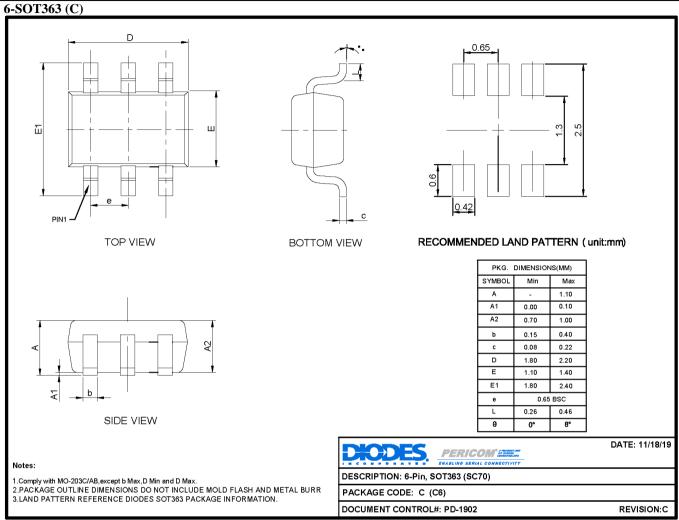








Packaging Mechanical



19-1160

For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

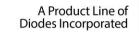
Ordering Information

Part Number	Packaging Code	Package Description
PSMUX1248CEX	С	6-Pin, SOT363 (SC70)

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. E = Pb-free and Green
- 5. X suffix = Tape/Reel







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